

IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100µm chip
- positive temperature coefficient
- easy paralleling

This chip is used for:

• IGBT-Modules



Applications:

• drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code	
SIGC07T60NC	600V	6A	2.6 x 2.6 mm ²	sawn on foil	Q67050-A4134-	
	0001	0/1	2.0 X 2.0 11111	oawii oii ioii	A001	

MECHANICAL PARAMETER:

Raster size	2.6 x 2.6				
Area total / active	6.76 / 4.3				
Emitter pad size	1.11 x 1.78				
Gate pad size	0.5 x 0.7				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	0	deg			
Max.possible chips per wafer	2249				
Passivation frontside	Photoimide				
Emitter metallization	metallization 3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	18	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Tarameter		Conditions	min.	typ.	max.	01
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V, I_{C} =500 μ A	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =6A	1.7	2.0	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=200\mu A,\ V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V			0.5	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V, V _{GE} =20V			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
i arameter	Symbol		min.	typ.	max.	
Input capacitance	Ciss	V _{CE} =25V,		222		pF
Output capacitance	Coss	$V_{GE}=0V$,		-		
Reverse transfer capacitance	C_{rss}	f=1MHz		20		1

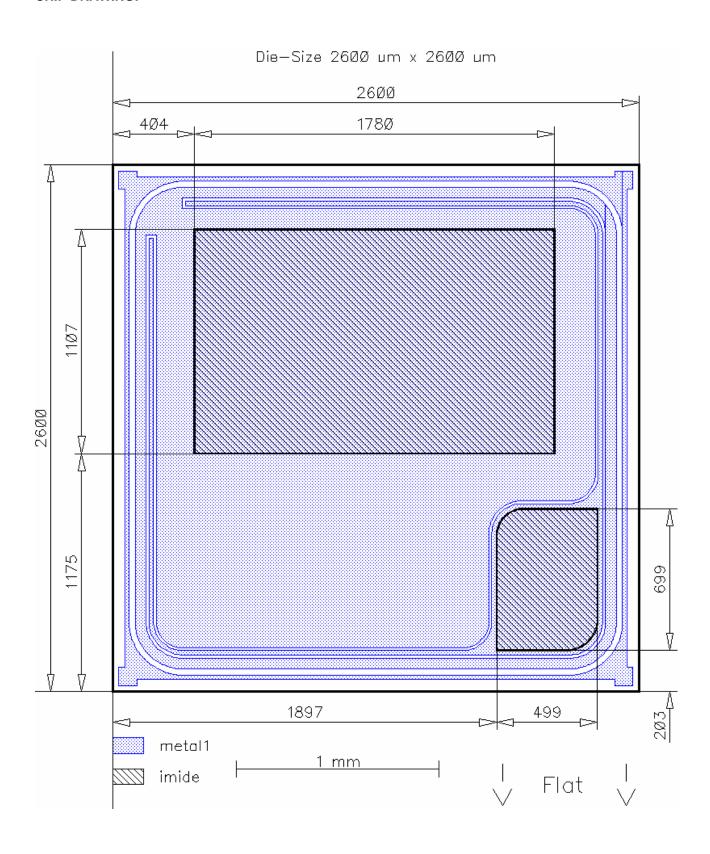
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions ²⁾	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C <i>V</i> _{CC} =300V		21		ns
Rise time	$t_{\rm r}$	I _C =6A		8		
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =±15V $R_{\rm G}$ =54 Ω		110		
Fall time	t_{f}	7.G-0422		25		

²⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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